

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

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Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 16.0003-04
CB Certificate No.: 20003698 ITL

Schedule Number: IECQ-L ULTW 16.0003-04-S Rev No.: 10 Revision Date: 2025/06/29 Page 1 of 3

Appendix-1 (20003698 ITL) Schedule of Scope to Certificate of Approval

Description test	Standard		
High Temperature Operation Life test (HTOL)	IEC 60068-2-1, JESD22-A108		
Low Temperature Operation Life test (LTOL)	IEC 60068-2-1, JESD22-A108		
Early Life Failure Rate (ELFR)	JESD22-A-108,AEC-Q100-008		
Bias Life test (BLT)	JESD22-A108		
Temperature Cycling test (TCT)	JESD22-A104		
Temperature variation test (TCC)	IEC 60068-2-14/33		
Thermal Shock test (TST)	JESD22-A106		
High Temperature Storage test (HTST)	IEC 60068-2-2, JESD22-A103		
Low Temperature Storage test (LTST)	IEC 60068-2-1, JESD22-A119		
Pressure Cooker test (PCT/UB-HAST)	JESD22-A102, JESD22-A118		
Highly Accelerated Stress test (HAST)	JESD22-A110		
Temperature and Humidity Storage test (THST)	IEC 60068-2-3, JEDEC22 A101		
Temperature and Humidity with Bias test (THB)	JESD22-A101		
Pre-conditioning test	JESD22-A113		
Reflow test	J-STD-020		
Solderability test	J-STD-002		

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Description test	Standard		
Steam aging test	J-STD-002		
Surface Mount Technology (SMT)	IPC-A-610, IPC-A-600		
Multi-function material test (Bending test)	JESD22-B113		
Drop test	ISTA 2A, IEC 60068-2-32		
Vibration test and Shock Test	IEC 60068-2-6/27/29/34/64		
Salt atmosphere street test	JESD22-A107, IEC 60068-2-11/52		
Gas corrosion test	IEC 60068-2-42/43/49/60		
Electro-migration test	IPC TM650 2.6.25		
Conductive resistance test	IPC 9701		
Low temperature/ low humidity test	IEC 60068-2-38/39		
Low pressure / altitude test	IEC 60068-2-13		
Dust and water proof test	IEC 60529		
Solar radiation test	IEC 60068-2-5/9		
Tumbling Test	IEC 60068-2-31		
Torque test	T-REL-3		
Carton Compression test	ISTA 2A, ASTM		
High Temperature Reverse Bias (HTRB)	MIL-STD-750 Method 1039		
High Humidity High Temperature Reverse Bias (H3TRB)	JESD22-A-101		
High Temperature Gate Bias (HTGB)	JESD22-A-108		
Intermittent Operational Life (IOL)	MIL-STD-750 Method 1037, JESD22-A-122		

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Description test	Standard		
IP5KX(Arizona dust)	ISO 20653		
Package Warpage Measurement	JESD22-B112		
Lead Integrity	JESD22-B105		
Die Strength	SEMI G86		

	Paul	Young		
Technical Reviewer of DQS: _		/	 Date:	6/29/2025

